

<b>Notice of References Cited</b>	Application/Control No. 09/931,239	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner David W. Scheuermann	Art Unit 2834	Page 1 of 2

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-2,981,855	04-1961	RIGGS WILLIAM D; et. al.	310/163
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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